

General Description

The AON7410 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in DC - DC converters and Load Switch applications.

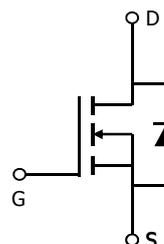
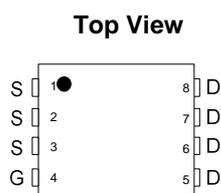
Features

$$V_{DS} (V) = 30V$$

$$I_D = 24A \quad (V_{GS} = 10V)$$

$$R_{DS(ON)} < 20m\Omega \quad (V_{GS} = 10V)$$

$$R_{DS(ON)} < 26m\Omega \quad (V_{GS} = 4.5V)$$



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units | |
|---|------------------|-------------------------|------------------|-----|
| Drain-Source Voltage | V_{DS} | 30 | V | |
| Gate-Source Voltage | V_{GS} | ± 20 | V | |
| Continuous Drain Current ^B | I_D | 24 | A | |
| Current ^B | | $T_C=100^\circ\text{C}$ | | 15 |
| Pulsed Drain Current ^C | | I_{DM} | | 50 |
| Continuous Drain Current ^A | I_{DSM} | 9.5 | A | |
| Current ^A | | $T_A=70^\circ\text{C}$ | | 7.7 |
| Avalanche Current ^C | I_{AS}, I_{AR} | 17 | A | |
| Repetitive avalanche energy $L=0.1\text{mH}$ ^C | E_{AS}, E_{AR} | 14 | mJ | |
| Power Dissipation ^B | P_D | $T_C=25^\circ\text{C}$ | 20 | W |
| | | $T_C=100^\circ\text{C}$ | 8.3 | |
| Power Dissipation ^A | P_{DSM} | $T_A=25^\circ\text{C}$ | 3.1 | |
| | | $T_A=70^\circ\text{C}$ | 2 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | $^\circ\text{C}$ | |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|--------------|-----|---------------------------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 30 | 40 | $^\circ\text{C}/\text{W}$ |
| Maximum Junction-to-Ambient ^A | | Steady-State | 60 | 75 |
| Maximum Junction-to-Case ^B | $R_{\theta JC}$ | 5 | 6 | $^\circ\text{C}/\text{W}$ |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|----------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 30 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =30V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} = ±20V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} I _D =250μA | 1.4 | 1.8 | 2.5 | V |
| I _{D(ON)} | On state drain current | V _{GS} =10V, V _{DS} =5V | 50 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =8A T _J =125°C | | 16 24 | 20 29 | mΩ |
| | | V _{GS} =4.5V, I _D =7A | | 21 | 26 | |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =8A | | 30 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.75 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 20 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =15V, f=1MHz | 440 | 550 | 660 | pF |
| C _{oss} | Output Capacitance | | 77 | 110 | 143 | pF |
| C _{rss} | Reverse Transfer Capacitance | | 33 | 55 | 77 | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 3 | 4 | 4.9 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g (10V) | Total Gate Charge | V _{GS} =10V, V _{DS} =15V, I _D =8A | 7.8 | 9.8 | 12 | nC |
| Q _g (4.5V) | Total Gate Charge | | 3.6 | 4.6 | 5.5 | nC |
| Q _{gs} | Gate Source Charge | | 1.4 | 1.8 | 2.2 | nC |
| Q _{gd} | Gate Drain Charge | | 1.3 | 2.2 | 3 | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =15V, R _L =2Ω, R _{GEN} =3Ω | | 5 | | ns |
| t _r | Turn-On Rise Time | | | 3.2 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 24 | | ns |
| t _f | Turn-Off Fall Time | | | 6 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =8A, di/dt=500A/μs | 7 | 9 | 11 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =8A, di/dt=500A/μs | 12 | 15 | 18 | nC |

A: The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} t ≤ 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150° C may be used if the PCB allows it.

B: The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C.

D: The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300ms pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

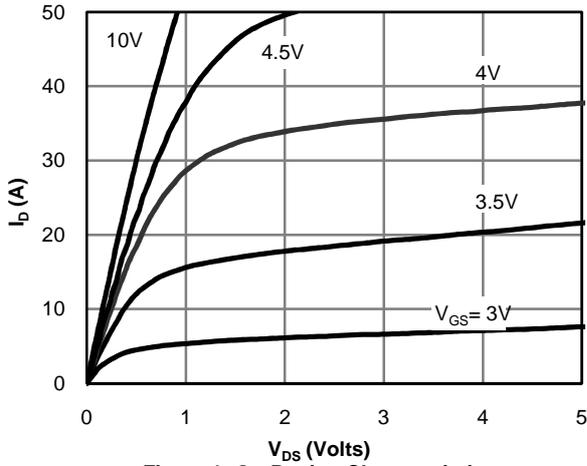


Figure 1: On-Region Characteristics

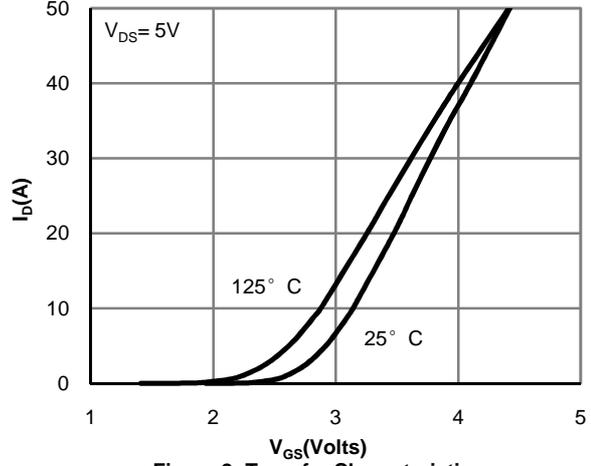


Figure 2: Transfer Characteristics

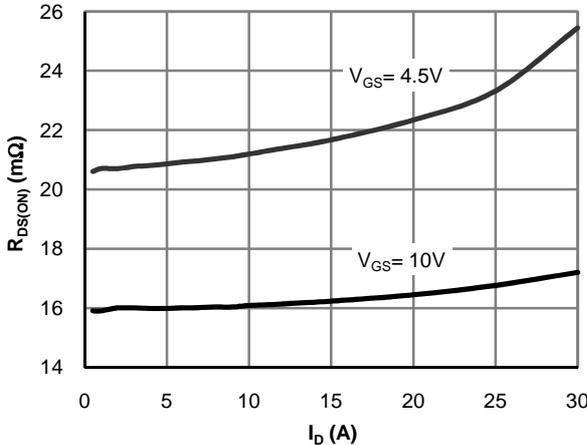


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

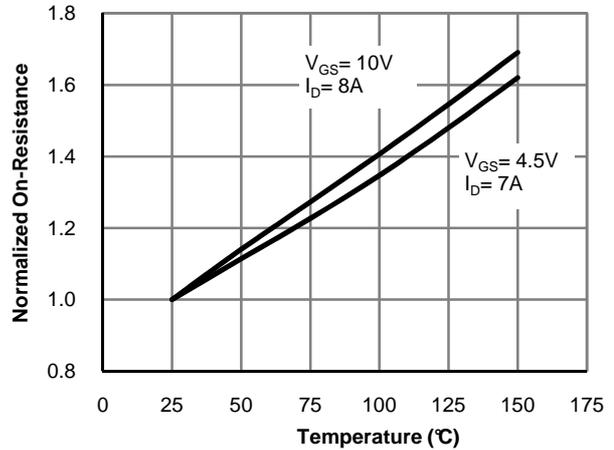


Figure 4: On-Resistance vs. Junction Temperature

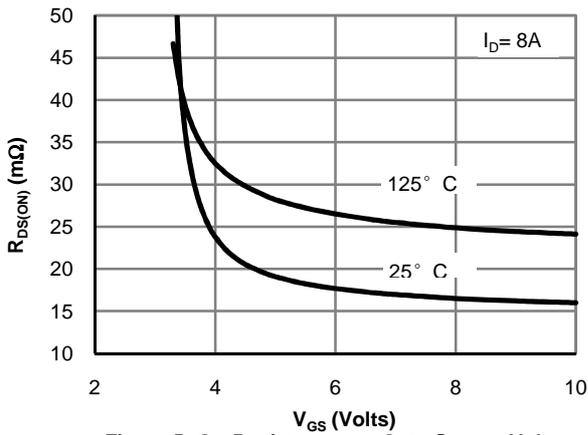


Figure 5: On-Resistance vs. Gate-Source Voltage

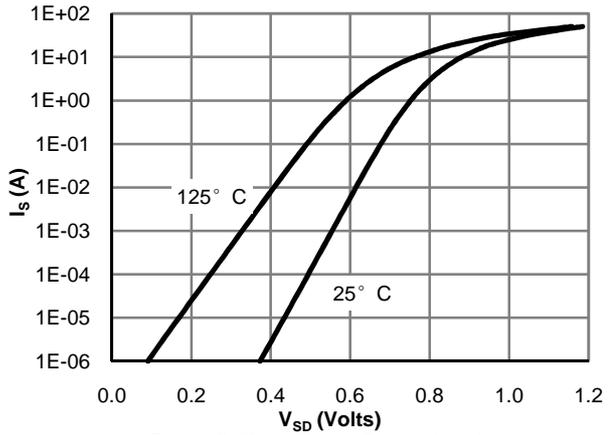


Figure 6: Body-Diode Characteristics

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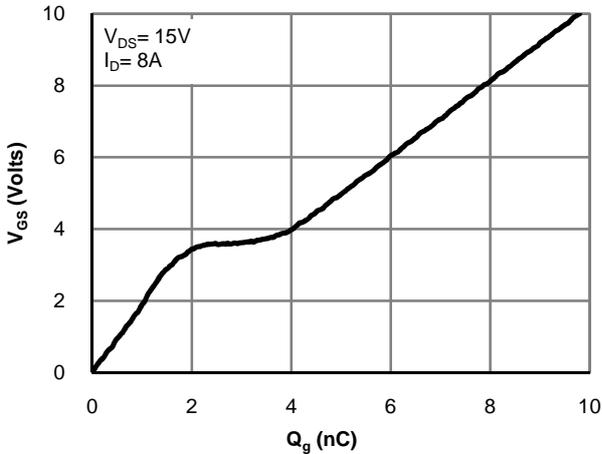


Figure 7: Gate-Charge Characteristics

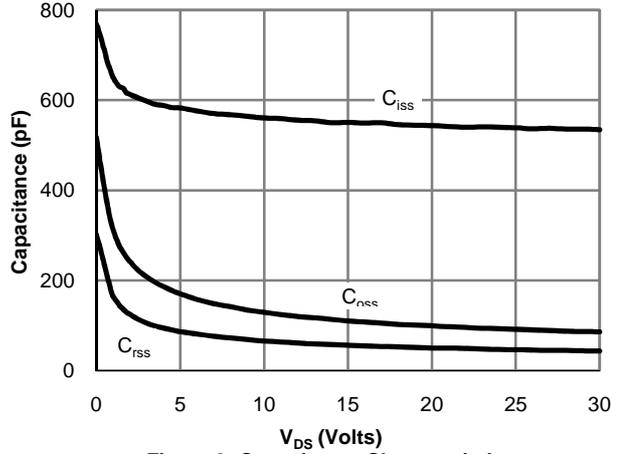


Figure 8: Capacitance Characteristics

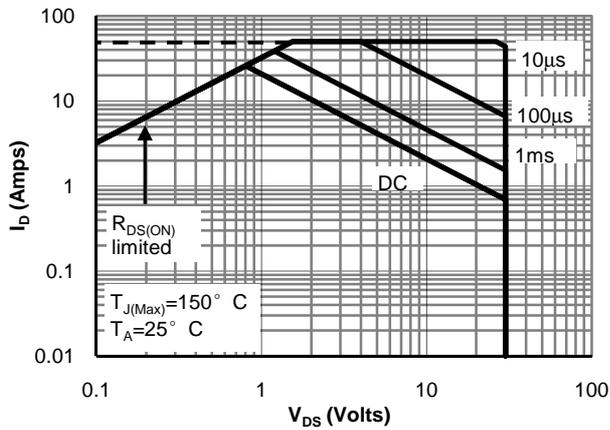


Figure 9: Maximum Forward Biased Safe Operating Area (Note H)

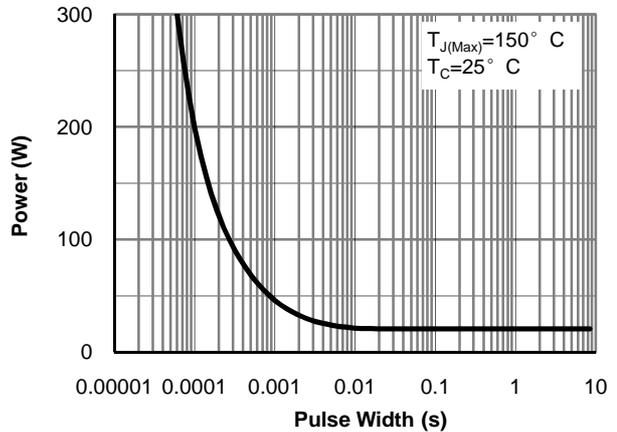


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

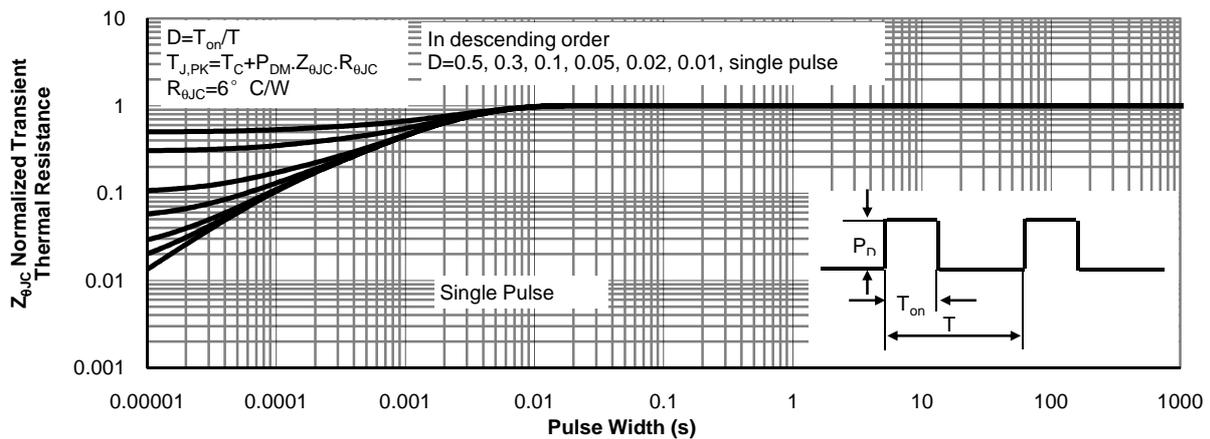


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

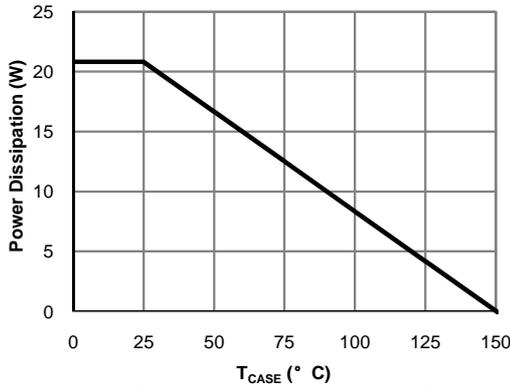


Figure 12: Power De-rating (Note F)

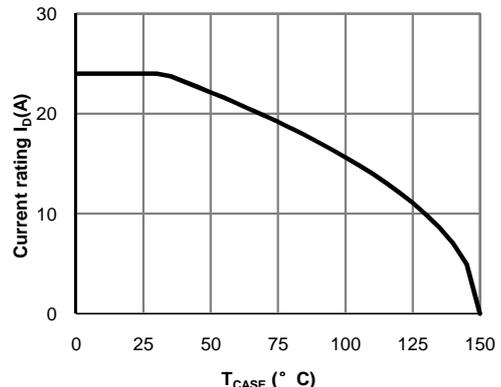


Figure 13: Current De-rating (Note F)

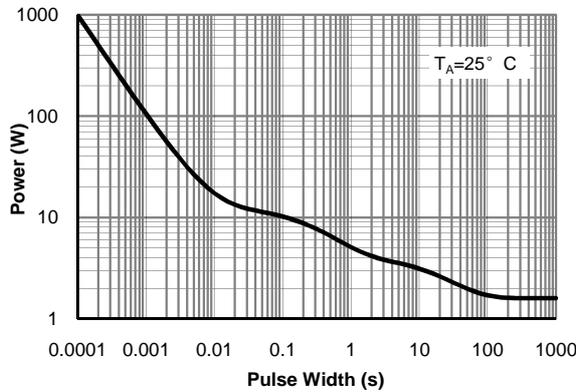


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

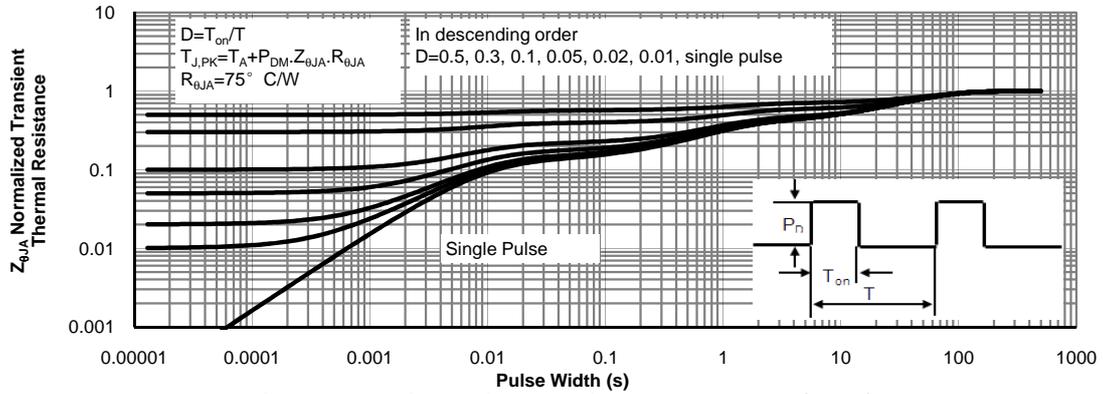
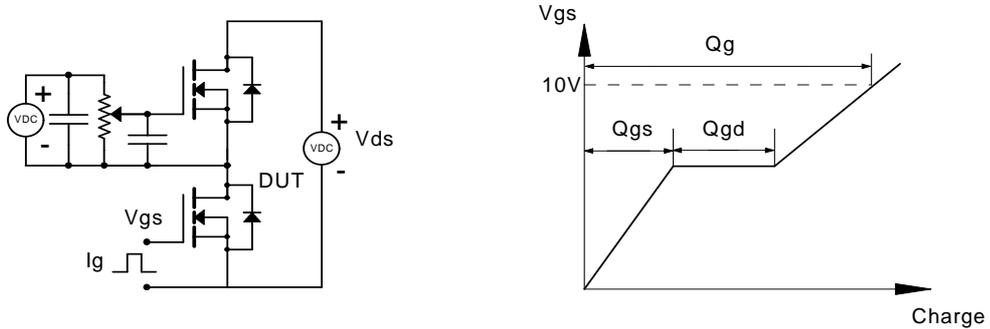
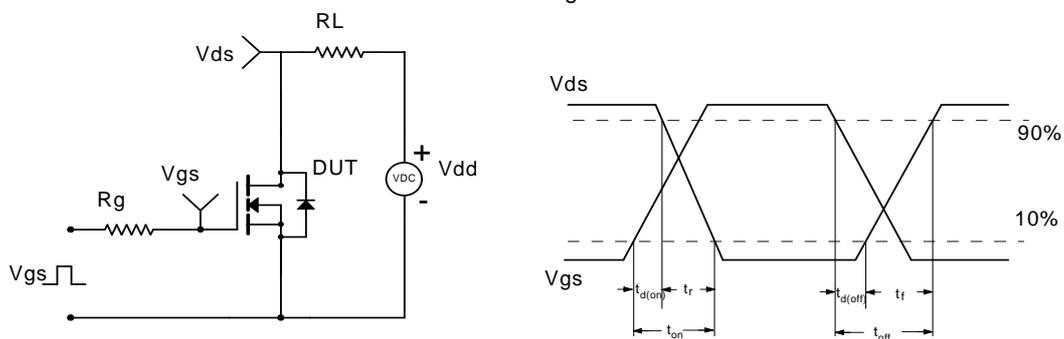


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

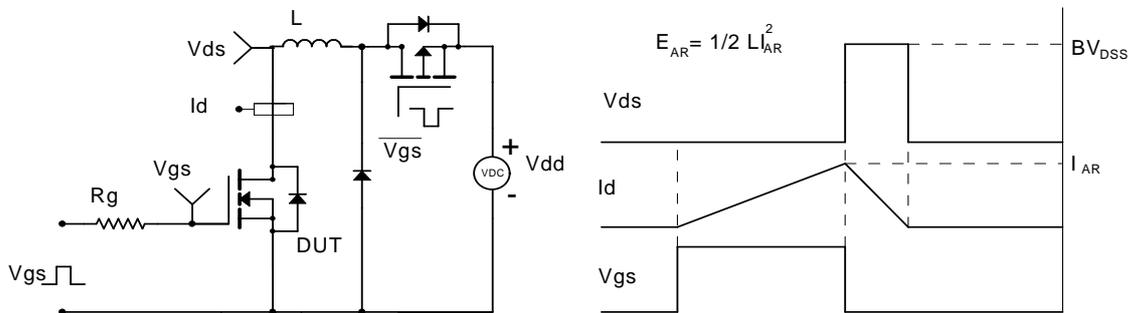
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

